

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10572525	KANG ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	KHIEM D NGUYEN	2823

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
438	15,26,122,612	4/27/2009	/KN/
257	67,E21.476,E21.506,E21.531,E29.089,E33.075,E21.531	4/27/2009	/KN/

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	4/27/2009	/KN/
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	4/21/2010	/KN/

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

	/KHIEM D NGUYEN/ Primary Examiner.Art Unit 2823
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